

# G2R120MT33-CAL

## 3300 V 120 mΩ SiC MOSFET



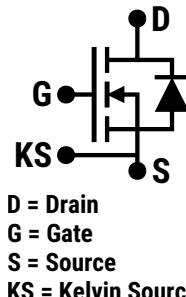
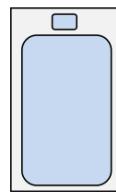
Silicon Carbide MOSFET  
N-Channel Enhancement Mode

$V_{DS}$	=	3300 V
$R_{DS(ON)}(\text{Typ.})$	=	120 mΩ
$I_D(T_c = 100^\circ\text{C})$	=	23 A

### Features

- G2R™ Technology with +20 V Gate Drive
- Superior  $Q_G \times R_{DS(ON)}$  Figure of Merit
- Superior Cost-Performance Index
- Low Capacitances and Low Gate Charge
- Fast and Reliable Body Diode
- Low Losses at All Temperatures
- Optimized Package with Separate Driver Source Pin

### Bare Chip



### Advantages

- Compatible with Commercial Gate Drivers
- Increased Power Density for Compact System
- High Frequency Switching
- Improved Thermal Capability
- Ease of Paralleling without Thermal Runaway

### Applications

- Solar String Inverters
- EV- Fast Chargers
- Pulsed Power
- Switched Mode Power Supply
- Energy Storage
- Solid State Transformers
- Solid State Circuit Breakers

### Absolute Maximum Ratings (At $T_C = 25^\circ\text{C}$ Unless Otherwise Stated)

Parameter	Symbol	Conditions	Values	Unit	Note
Drain-Source Voltage	$V_{DS(\text{max})}$	$V_{GS} = 0 \text{ V}, I_D = 100 \mu\text{A}$	3300	V	
Gate-Source Voltage (Dynamic)	$V_{GS(\text{max})}$		-10 / +25	V	
Gate-Source Voltage (Static)	$V_{GS(\text{op})}$	Recommended Operation	-5 / +20	V	
Continuous Forward Current	$I_D$	$T_C = 25^\circ\text{C}, V_{GS} = -5 / +20 \text{ V}$	32		
		$T_C = 100^\circ\text{C}, V_{GS} = -5 / +20 \text{ V}$	23	A	
		$T_C = 135^\circ\text{C}, V_{GS} = -5 / +20 \text{ V}$	17		
Pulsed Drain Current	$I_{D(\text{pulse})}$	$t_P \leq 3\mu\text{s}, D \leq 1\%, V_{GS} = 20 \text{ V}$ , Note 1	100	A	
Power Dissipation	$P_D$	$T_c = 25^\circ\text{C}$	328	W	Note 2
Non-Repetitive Avalanche Energy	$E_{AS}$	$L = 34.0 \text{ mH}, I_{AS} = 7.5 \text{ A}$	955	mJ	
Operating and Storage Temperature	$T_j, T_{stg}$		-55 to 175	°C	

Note 1: Pulse Width  $t_P$  Limited by  $T_{j(\text{max})}$

Note 2: Assuming  $R_{th,JC(\text{max})} = 0.46^\circ\text{C}/\text{W}$



**Electrical Characteristics (At  $T_C = 25^\circ\text{C}$  Unless Otherwise Stated)**

Parameter	Symbol	Conditions	Values	Unit	Note
			Min.	Typ.	Max.
Drain-Source Breakdown Voltage	$V_{DSS}$	$V_{GS} = 0 \text{ V}, I_D = 100 \mu\text{A}$	3300		V
Zero Gate Voltage Drain Current	$I_{DSS}$	$V_{DS} = 3300 \text{ V}, V_{GS} = 0 \text{ V}$		1	$\mu\text{A}$
Gate Source Leakage Current	$I_{GSS}$	$V_{DS} = 0 \text{ V}, V_{GS} = 25 \text{ V}$ $V_{DS} = 0 \text{ V}, V_{GS} = -10 \text{ V}$		100 -100	nA
Gate Threshold Voltage	$V_{GS(\text{th})}$	$V_{DS} = V_{GS}, I_D = 4.0 \text{ mA}$ $V_{DS} = V_{GS}, I_D = 4.0 \text{ mA}, T_j = 175^\circ\text{C}$	2.5 3.40	4.50	V Fig. 9
Transconductance	$g_f$	$V_{DS} = 10 \text{ V}, I_D = 15 \text{ A}$ $V_{DS} = 10 \text{ V}, I_D = 15 \text{ A}, T_j = 175^\circ\text{C}$		5.8 6.3	S Fig. 4
Drain-Source On-State Resistance	$R_{DS(\text{ON})}$	$V_{GS} = 20 \text{ V}, I_D = 15 \text{ A}$ $V_{GS} = 20 \text{ V}, I_D = 15 \text{ A}, T_j = 175^\circ\text{C}$		120 246	156 mΩ Fig. 5-8
Input Capacitance	$C_{iss}$			3099	
Output Capacitance	$C_{oss}$			55	pF Fig. 11
Reverse Transfer Capacitance	$C_{rss}$	$V_{DS} = 1000 \text{ V}, V_{GS} = 0 \text{ V}$ $f = 1 \text{ MHz}, V_{AC} = 25 \text{ mV}$		5.2	
$C_{oss}$ Stored Energy	$E_{oss}$			36	μJ Fig. 12
$C_{oss}$ Stored Charge	$Q_{oss}$			108	nC
Gate-Source Charge	$Q_{gs}$	$V_{DS} = 1000 \text{ V}, V_{GS} = -5 / +20 \text{ V}$		41	
Gate-Drain Charge	$Q_{gd}$	$I_D = 15 \text{ A}$		43	nC Fig. 10
Total Gate Charge	$Q_g$	Per IEC607478-4		130	
Internal Gate Resistance	$R_{G(\text{int})}$	$f = 1 \text{ MHz}, V_{AC} = 25 \text{ mV}$		1.3	Ω
Turn-On Switching Energy (Body Diode)	$E_{on}$	$T_j = 25^\circ\text{C}; V_{GS} = -5/+20\text{V}; R_{G(\text{ext})} = 10 \Omega, I_D = 15 \text{ A}; V_{DD} = 1700 \text{ V}$		231	μJ Fig. 18
Turn-Off Switching Energy (Body Diode)	$E_{off}$			137	
Turn-On Delay Time	$t_{d(on)}$			83	
Rise Time	$t_r$	$V_{DD} = 1700 \text{ V}, V_{GS} = -5/+20 \text{ V}$ $R_{G(\text{ext})} = 10 \Omega, I_D = 15 \text{ A}$		26	ns Fig. 20
Turn-Off Delay Time	$t_{d(off)}$	Timing relative to $V_{DS}$ , Resistive load		32	
Fall Time	$t_f$			19	

**Reverse Diode Characteristics**

Parameter	Symbol	Conditions	Values	Unit	Note
			Min.	Typ.	Max.
Diode Forward Voltage	$V_{SD}$	$V_{GS} = -5 \text{ V}, I_{SD} = 7 \text{ A}$ $V_{GS} = -5 \text{ V}, I_{SD} = 7 \text{ A}, T_j = 175^\circ\text{C}$	4.0 3.4		V Fig. 13-14
Continuous Diode Forward Current	$I_s$	$V_{GS} = -5 \text{ V}, T_c = 100^\circ\text{C}$	27		A
Diode Pulse Current	$I_{S(\text{pulse})}$	$V_{GS} = -5 \text{ V}$ , Note 1	108		A
Reverse Recovery Time	$t_{rr}$	$V_{GS} = -5 \text{ V}, I_{SD} = 15 \text{ A}, V_R = 1700 \text{ V}$	72		ns
Reverse Recovery Charge	$Q_{rr}$	$dif/dt = 500 \text{ A}/\mu\text{s}, T_j = 25^\circ\text{C}$	340		nC
Peak Reverse Recovery Current	$I_{rrm}$		8		A
Reverse Recovery Time	$t_{rr}$	$V_{GS} = -5 \text{ V}, I_{SD} = 15 \text{ A}, V_R = 1700 \text{ V}$	95		ns
Reverse Recovery Charge	$Q_{rr}$	$dif/dt = 500 \text{ A}/\mu\text{s}, T_j = 175^\circ\text{C}$	1305		nC
Peak Reverse Recovery Current	$I_{rrm}$		18		A

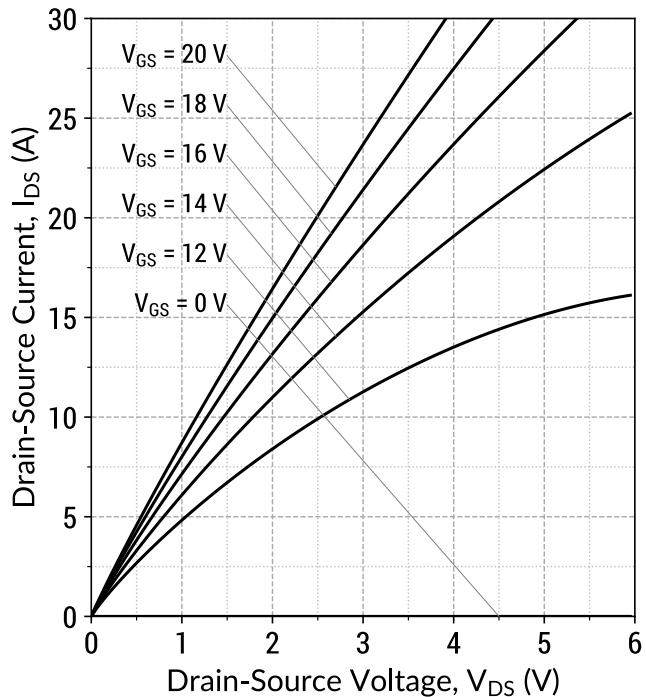
\*The chip technology was characterized up to 200 V/ns. The measured dV/dt was limited by measurement test setup and package.



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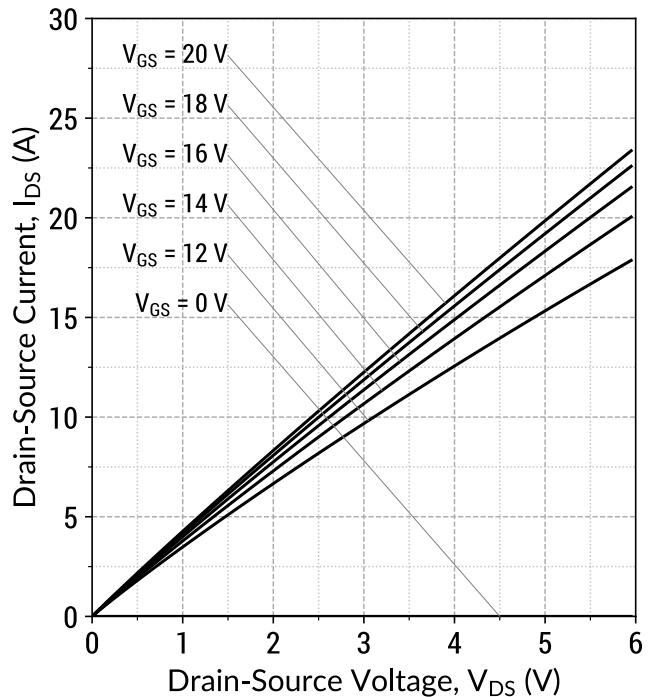


Figure 1: Output Characteristics ( $T_j = 25^\circ\text{C}$ )



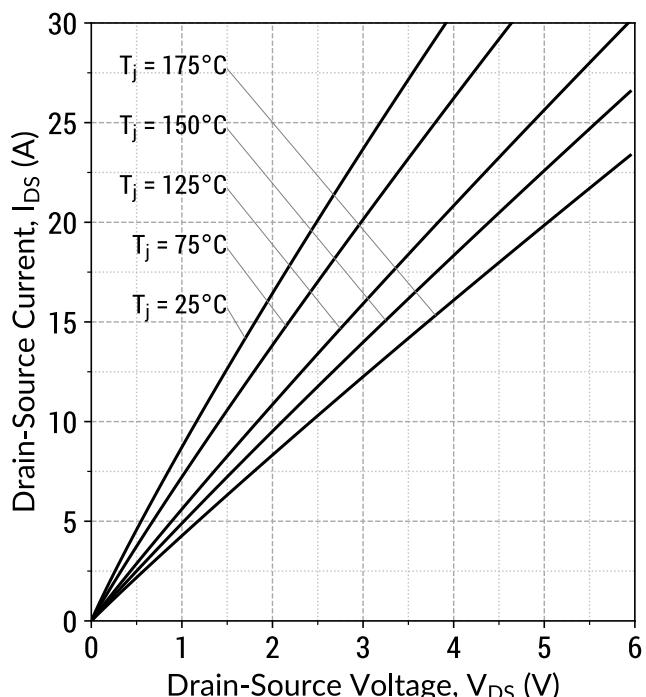
$$I_D = f(V_{DS}, V_{GS}); t_P = 250 \mu\text{s}$$

Figure 2: Output Characteristics ( $T_j = 175^\circ\text{C}$ )



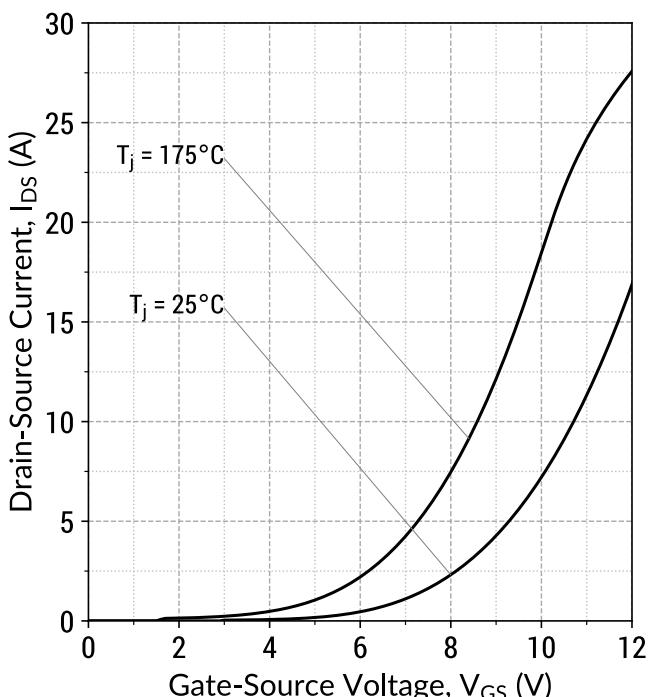
$$I_D = f(V_{DS}, V_{GS}); t_P = 250 \mu\text{s}$$

Figure 3: Output Characteristics ( $V_{GS} = 20\text{ V}$ )



$$I_D = f(V_{DS}, T_j); t_P = 250 \mu\text{s}$$

Figure 4: Transfer Characteristics ( $V_{DS} = 10\text{ V}$ )



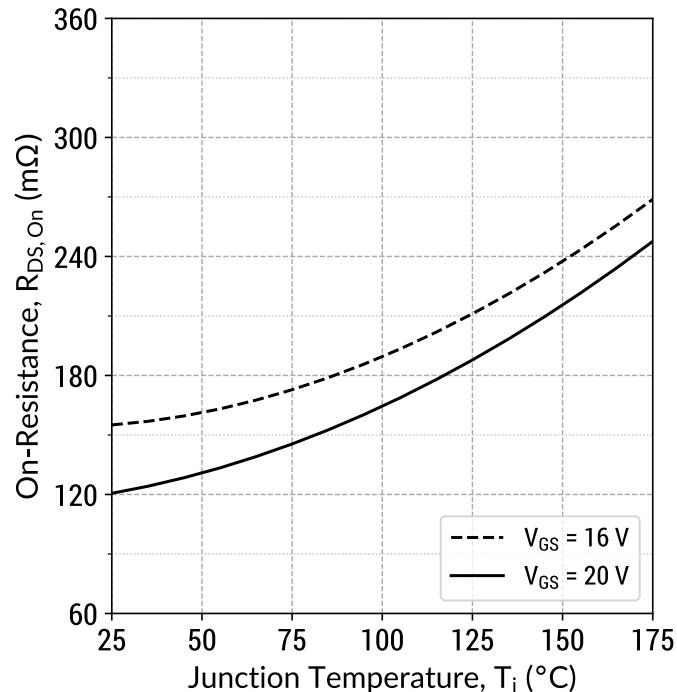
$$I_D = f(V_{GS}, T_j); t_P = 100 \mu\text{s}$$



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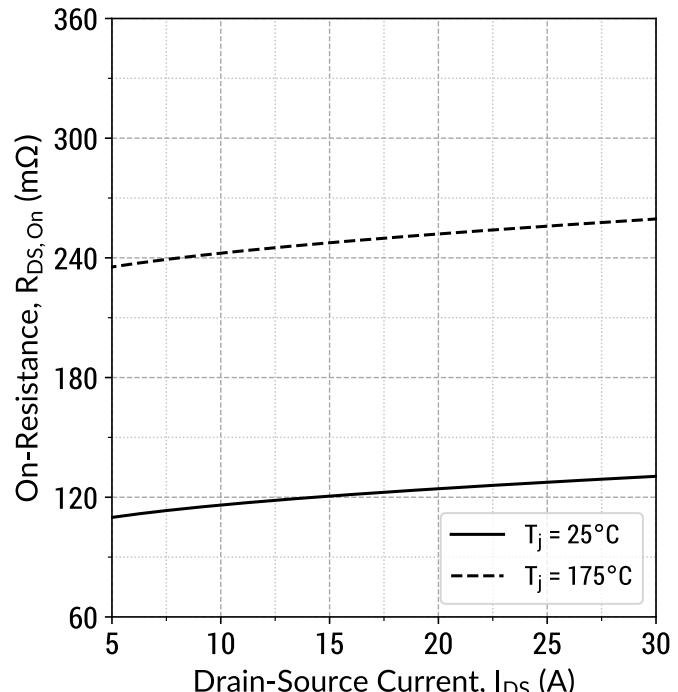


Figure 5: On-State Resistance v/s Temperature



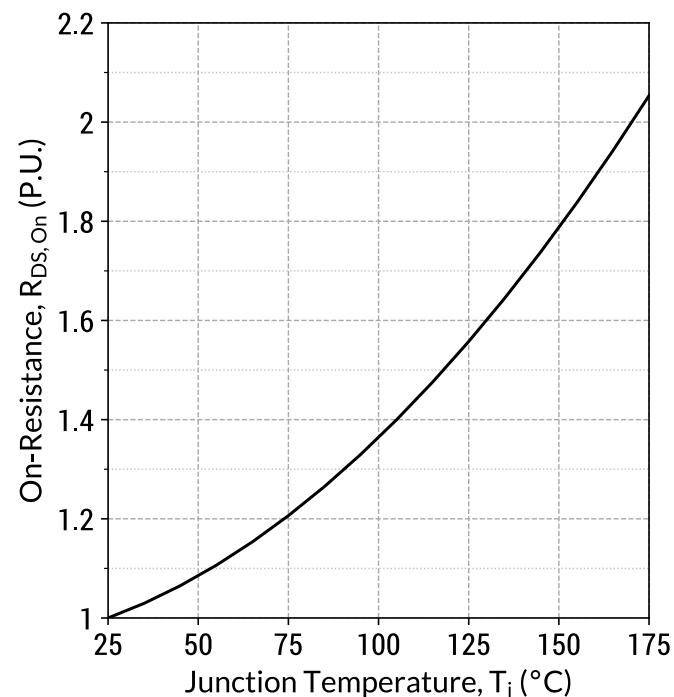
$$R_{DS(ON)} = f(T_j, V_{GS}); t_p = 250 \mu\text{s}; I_D = 15 \text{ A}$$

Figure 6: On-State Resistance v/s Drain Current



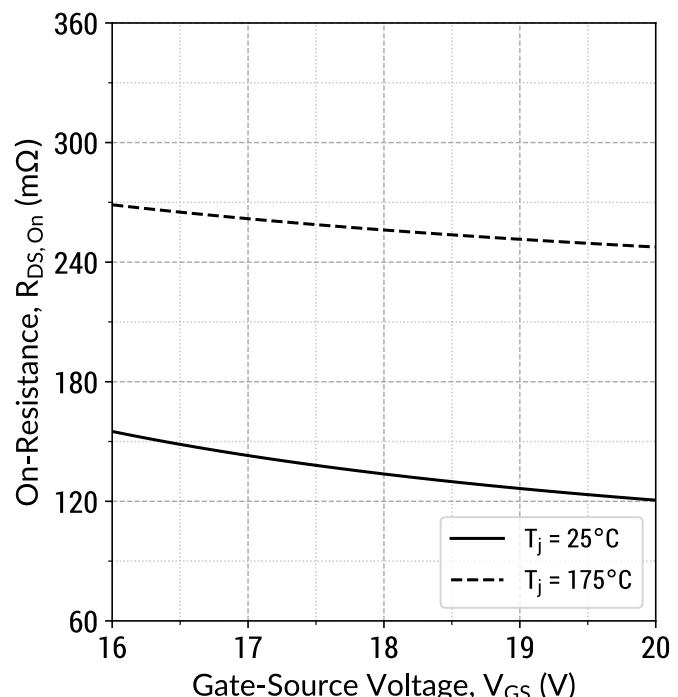
$$R_{DS(ON)} = f(T_j, I_{DS}); t_p = 250 \mu\text{s}; V_{GS} = 20 \text{ V}$$

Figure 7: Normalized On-State Resistance v/s Temperature



$$R_{DS(ON)} = f(T_j); t_p = 250 \mu\text{s}; I_D = 15 \text{ A}; V_{GS} = 20 \text{ V}$$

Figure 8: On-State Resistance v/s Gate Voltage

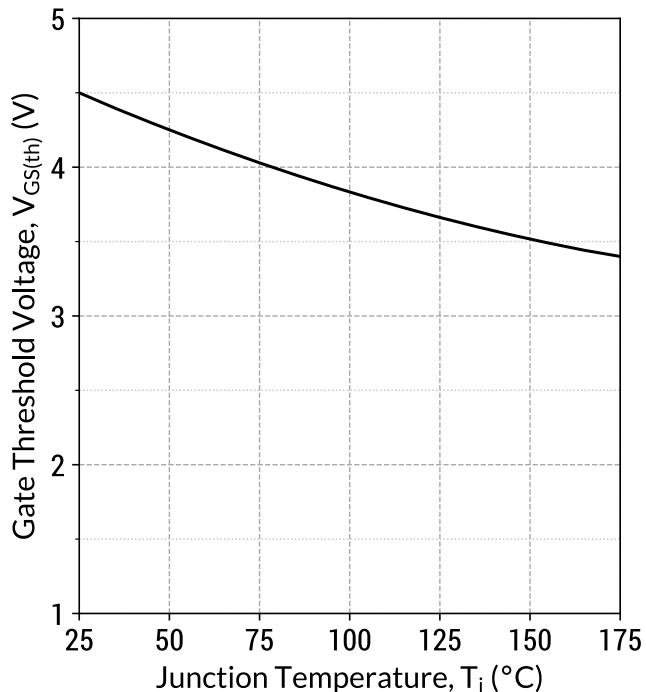


$$R_{DS(ON)} = f(T_j, V_{GS}); t_p = 250 \mu\text{s}; I_D = 15 \text{ A}$$



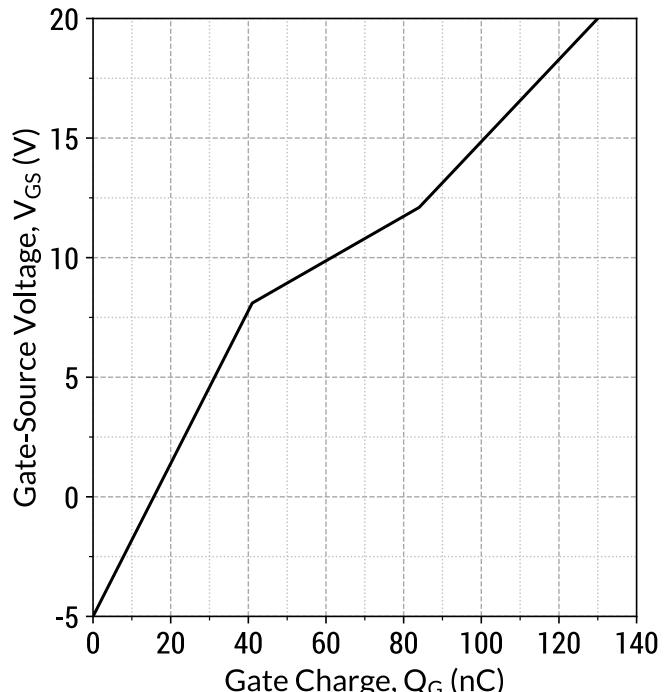
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**Figure 9: Threshold Voltage Characteristics**



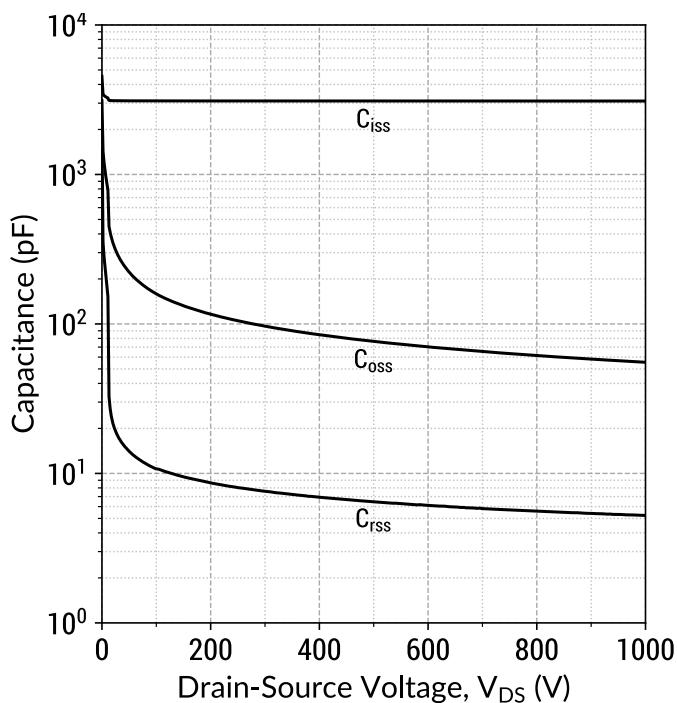
$V_{GS(th)} = f(T_j); V_{DS} = V_{GS}; I_D = 4.0 \text{ mA}$

**Figure 10: Gate Charge Characteristics**



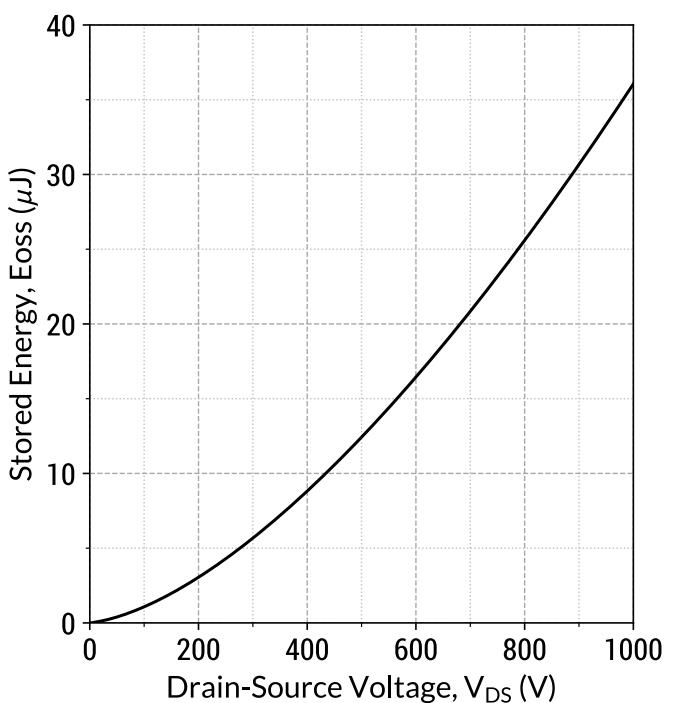
$I_D = 15 \text{ A}; V_{DS} = 1000 \text{ V}; T_c = 25^\circ\text{C}$

**Figure 11: Capacitance v/s Drain-Source Voltage**



$f = 1 \text{ MHz}; V_{AC} = 25 \text{ mV}$

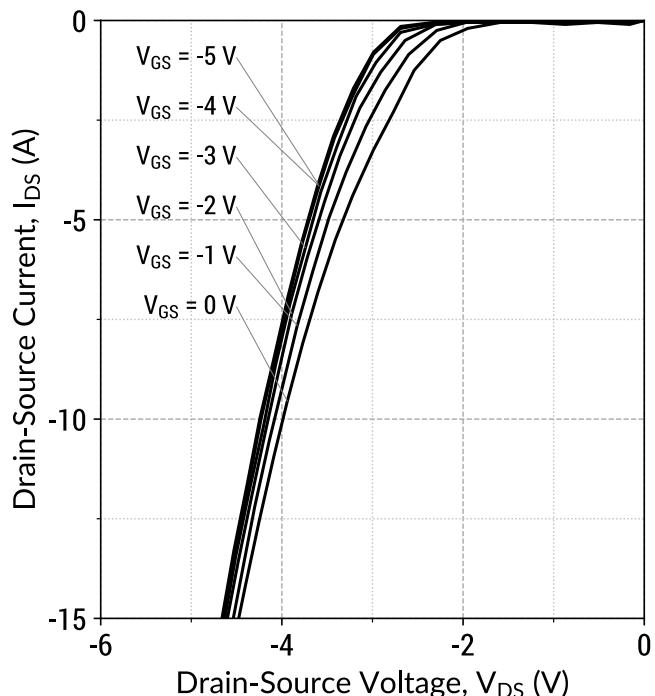
**Figure 12: Output Capacitor Stored Energy**



$E_{oss} = f(V_{DS})$

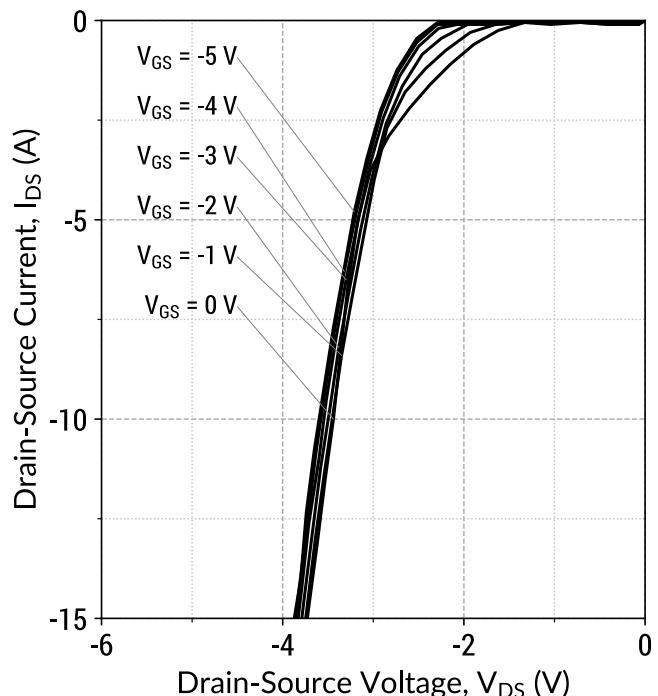
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Figure 13: Body Diode Characteristics ( $T_J = 25^\circ\text{C}$ )



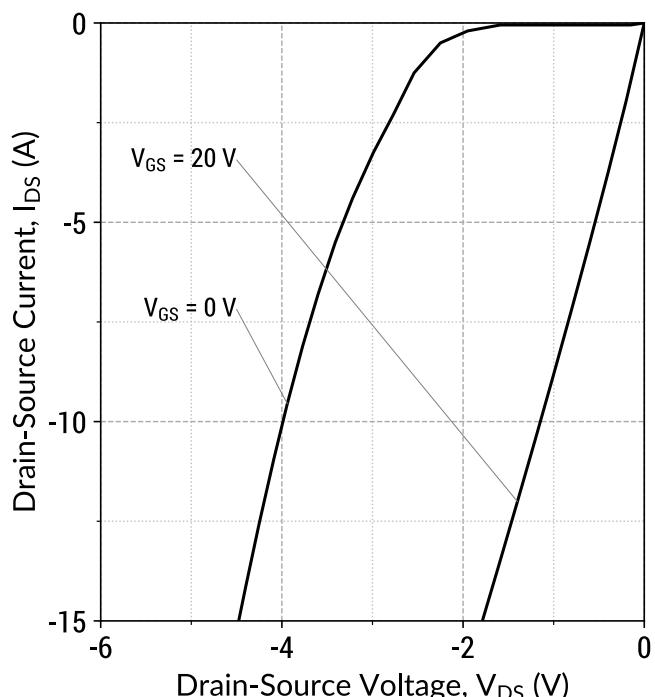
$$I_D = f(V_{DS}, V_{GS}); t_P = 250 \mu\text{s}$$

Figure 14: Body Diode Characteristics ( $T_J = 175^\circ\text{C}$ )



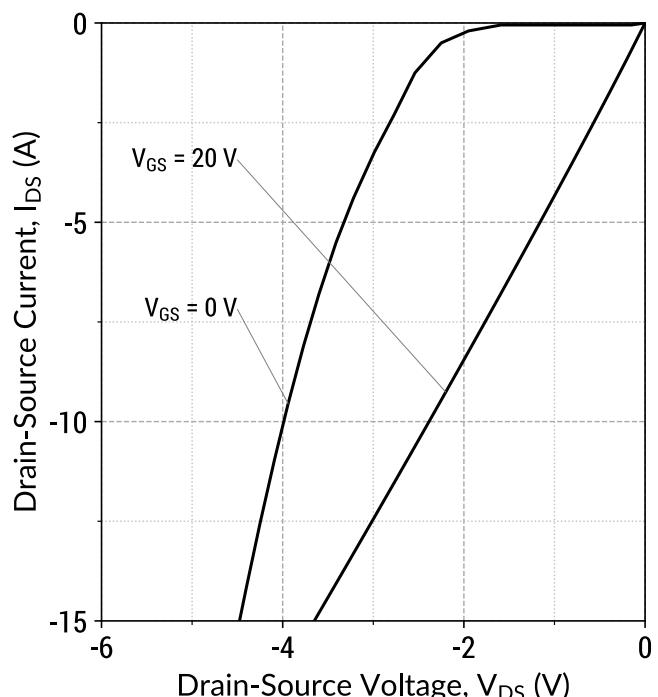
$$I_D = f(V_{DS}, V_{GS}); t_P = 250 \mu\text{s}$$

Figure 15: Third Quadrant Characteristics ( $T_J = 25^\circ\text{C}$ )



$$I_D = f(V_{DS}, V_{GS}); t_P = 250 \mu\text{s}$$

Figure 16: Third Quadrant Characteristics ( $T_J = 175^\circ\text{C}$ )

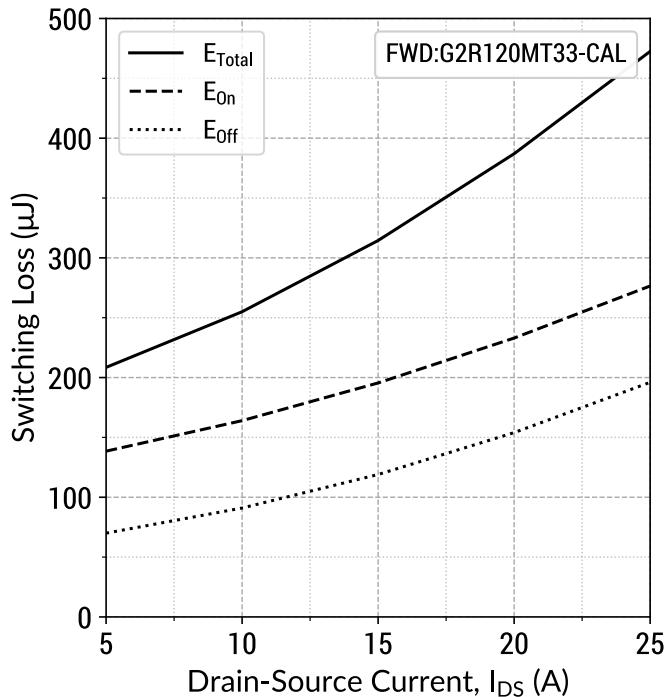


$$I_D = f(V_{DS}, V_{GS}); t_P = 250 \mu\text{s}$$

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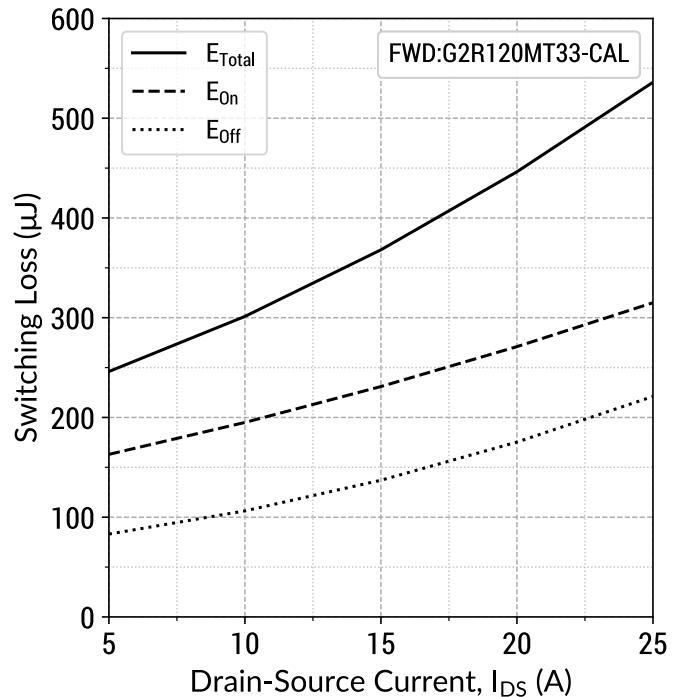
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Figure 17: Resistive Switching Energy v/s Drain Current  
( $V_{DD} = 1500V$ )



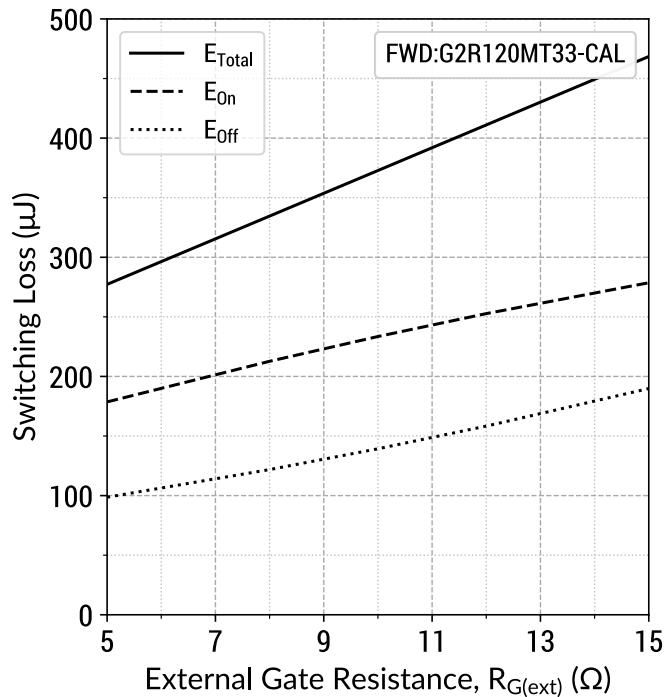
$T_j = 25^\circ C; V_{GS} = -5/+20V; R_{G(ext)} = 10 \Omega$

Figure 18: Resistive Switching Energy v/s Drain Current  
( $V_{DD} = 1700V$ )



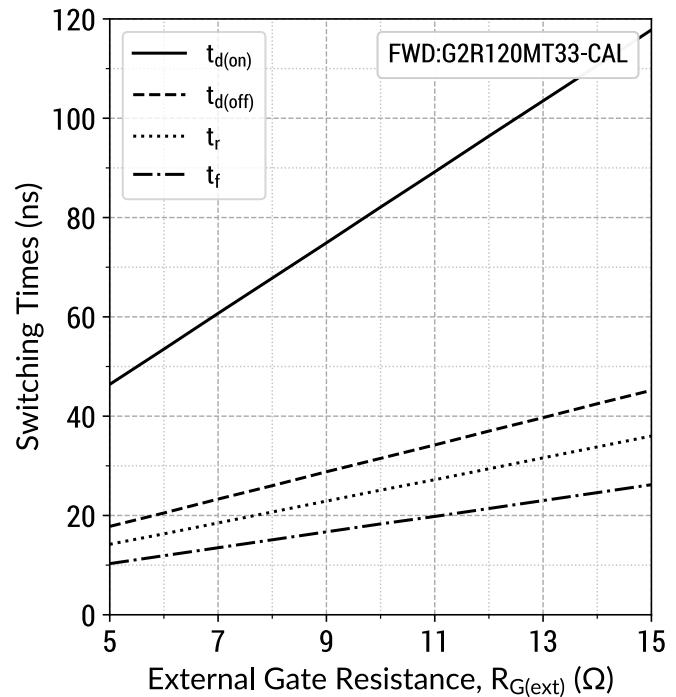
$T_j = 25^\circ C; V_{GS} = -5/+20V; R_{G(ext)} = 10 \Omega$

Figure 19: Resistive Switching Energy v/s  $R_{G(ext)}$   
( $V_{DD} = 1700V$ )



$T_j = 25^\circ C; V_{GS} = -5/+20V; I_{DS} = 15 A$

Figure 20: Switching Time v/s  $R_{G(ext)}$   
( $V_{DD} = 1700V$ )

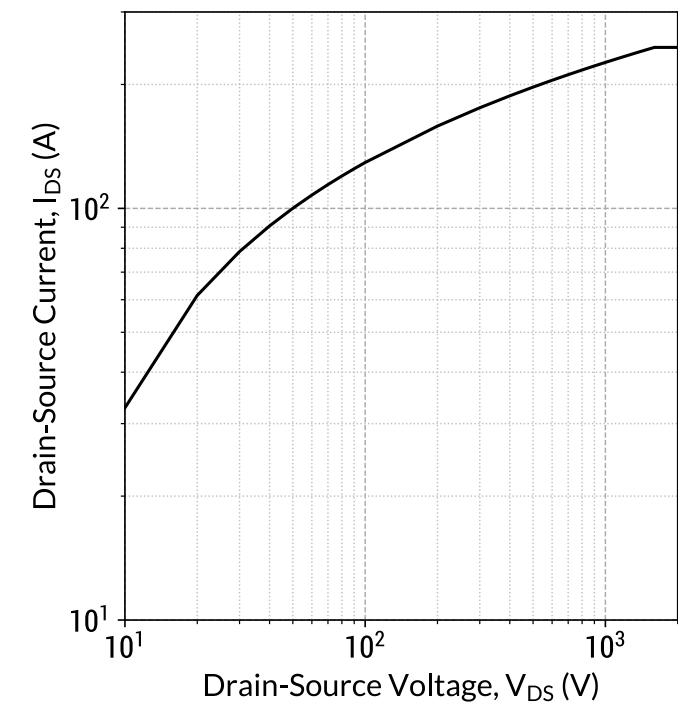


$T_j = 25^\circ C; V_{GS} = -5/+20V; I_{DS} = 15 A$

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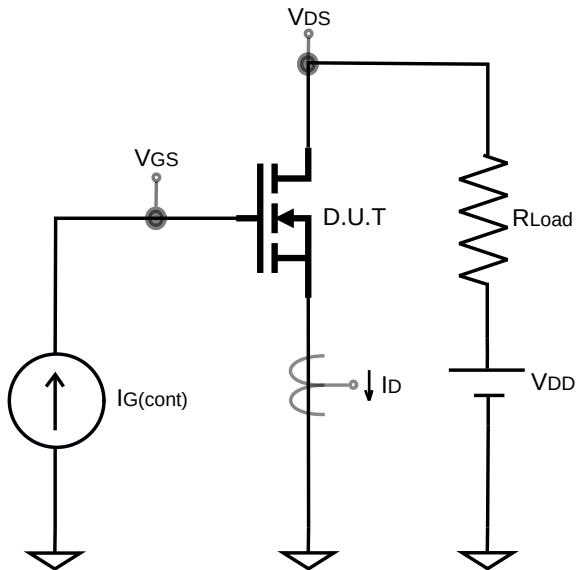
**Figure 21: High Current IV**



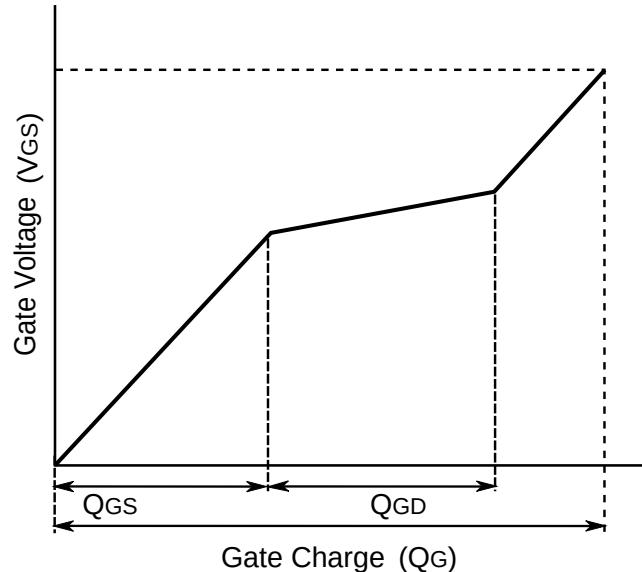
$I_D = f(V_{DS})$ ;  $t_P \leq 3 \mu\text{s}$ ;  $V_{GS} = 20 \text{ V}$



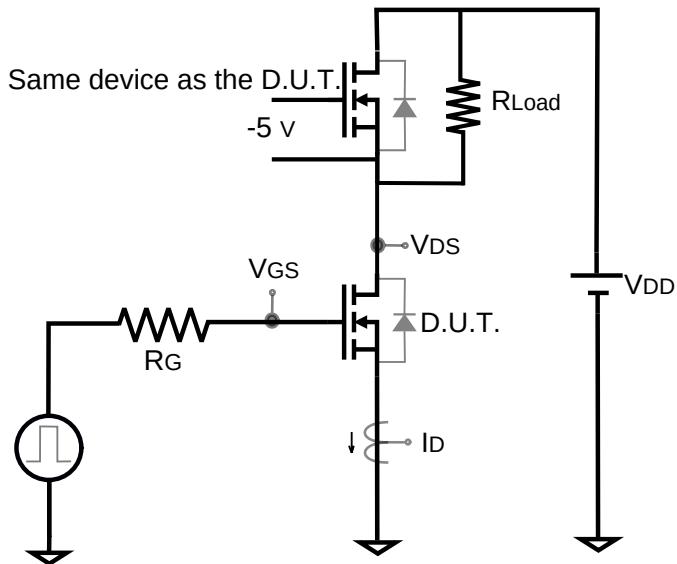
#### Gate Charge Circuit



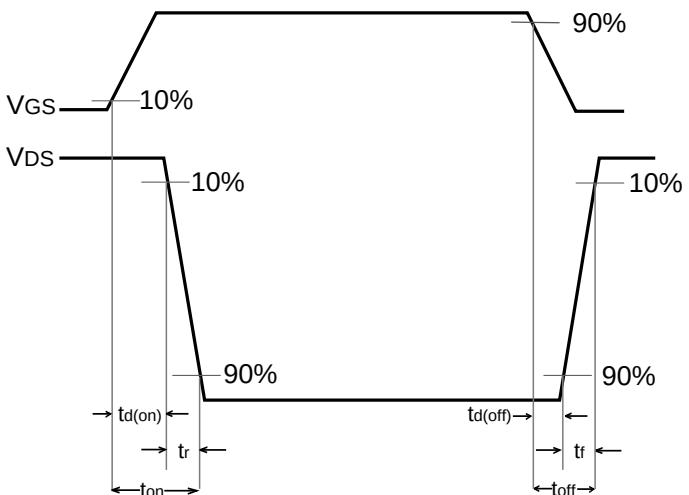
#### Gate Charge Waveform



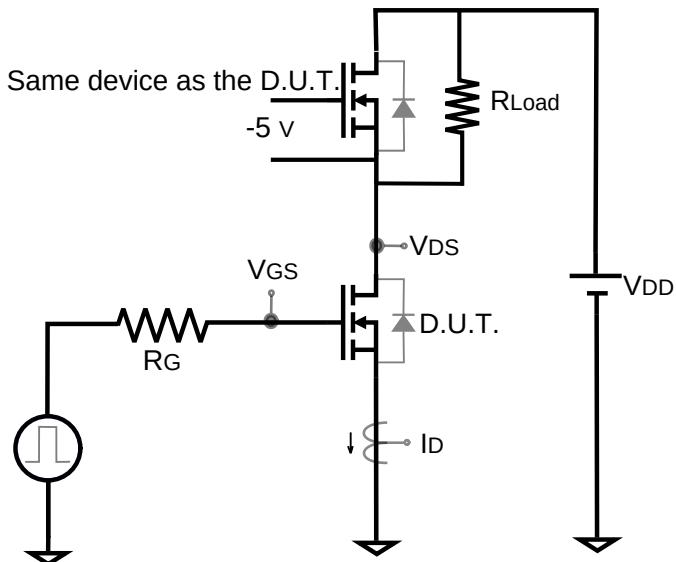
#### Switching Time Circuit



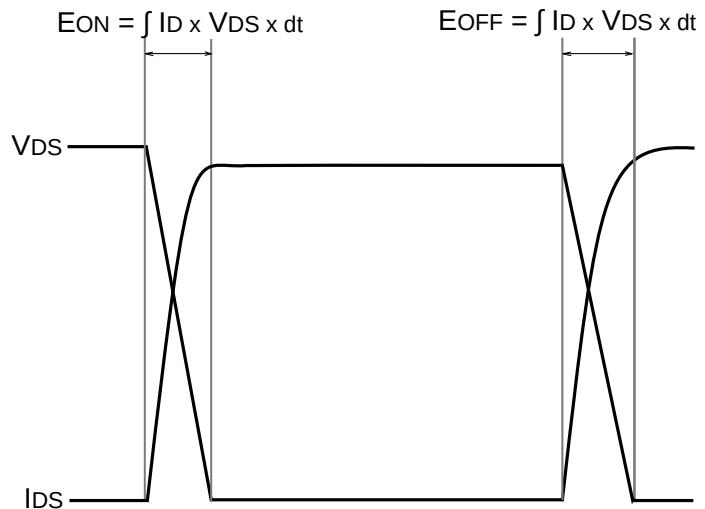
#### Switching Time Waveform



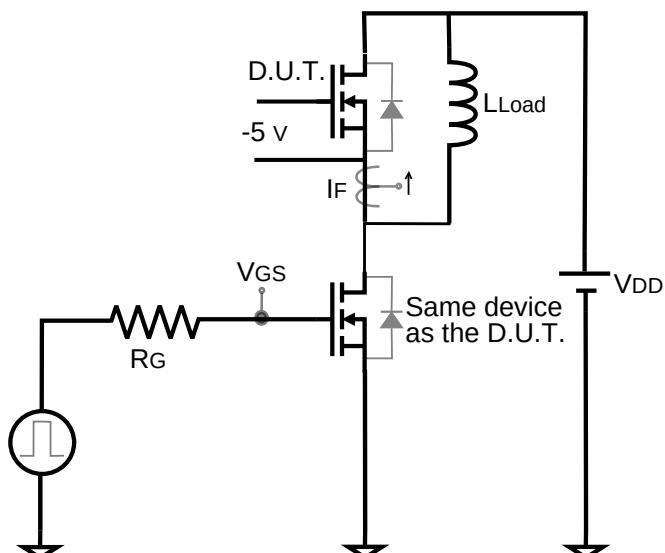
#### Switching Energy Circuit



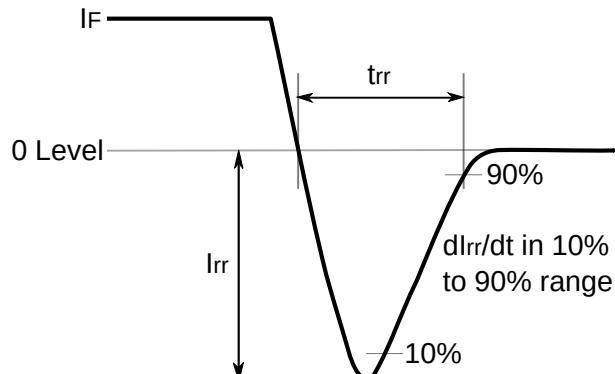
#### Switching Energy Waveform



#### Reverse Recovery Circuit



#### Reverse Recovery Waveform



## Mechanical Parameters

This information is **confidential**, please contact [sales@genesicsemi.com](mailto:sales@genesicsemi.com) to learn more.

## Chip Dimensions

This information is **confidential**, please contact [sales@genesicsemi.com](mailto:sales@genesicsemi.com) to learn more.

### NOTE

1. CONTROLLED DIMENSION IS MILLIMETER.
2. DIMENSIONS DO NOT INCLUDE END FLASH, MOLD FLASH, MATERIAL PROTRUSIONS.



## Compliance

### RoHS Compliance

The levels of RoHS restricted materials in this product are below the maximum concentration values (also referred to as the threshold limits) permitted for such substances, or are used in an exempted application, in accordance with EU Directive 2011/65/EC (RoHS 2), as adopted by EU member states on January 2, 2013 and amended on March 31, 2015 by EU Directive 2015/863. RoHS Declarations for this product can be obtained from your GeneSiC representative.

### REACH Compliance

REACH substances of high concern (SVHCs) information is available for this product. Since the European Chemical Agency (ECHA) has published notice of their intent to frequently revise the SVHC listing for the foreseeable future, please contact a GeneSiC representative to insure you get the most up-to-date REACH SVHC Declaration. REACH banned substance information (REACH Article 67) is also available upon request.

## Disclaimer

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Unless otherwise expressly indicated, GeneSiC products are not designed, tested or authorized for use in life-saving, medical, aircraft navigation, communication, air traffic control and weapons systems, nor in applications where their failure may result in death, personal injury and/or property damage.

## Related Links

- SPICE Models: [https://www.genesicsemi.com/sic-mosfet/G2R120MT33-CAL/G2R120MT33-CAL\\_SPICE.zip](https://www.genesicsemi.com/sic-mosfet/G2R120MT33-CAL/G2R120MT33-CAL_SPICE.zip)
- PLECS Models: [https://www.genesicsemi.com/sic-mosfet/G2R120MT33-CAL/G2R120MT33-CAL\\_PLECS.zip](https://www.genesicsemi.com/sic-mosfet/G2R120MT33-CAL/G2R120MT33-CAL_PLECS.zip)
- CAD Models: [https://www.genesicsemi.com/sic-mosfet/G2R120MT33-CAL/G2R120MT33-CAL\\_3D.zip](https://www.genesicsemi.com/sic-mosfet/G2R120MT33-CAL/G2R120MT33-CAL_3D.zip)
- Gate Driver Reference: <https://www.genesicsemi.com/technical-support>
- Evaluation Boards: <https://www.genesicsemi.com/technical-support>
- Reliability: <https://www.genesicsemi.com/reliability>
- Compliance: <https://www.genesicsemi.com/compliance>
- Quality Manual: <https://www.genesicsemi.com/quality>

## Revision History

- Rev 21/Jan: Updated with most recent test data
- Supersedes: Rev 20/Nov



[www.genesicsemi.com/sic-mosfet/](https://www.genesicsemi.com/sic-mosfet/)